

# Special Topics on Basic EECS I Design Technology Co-Optimization

## Lecture 18

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# L18

# Physical models

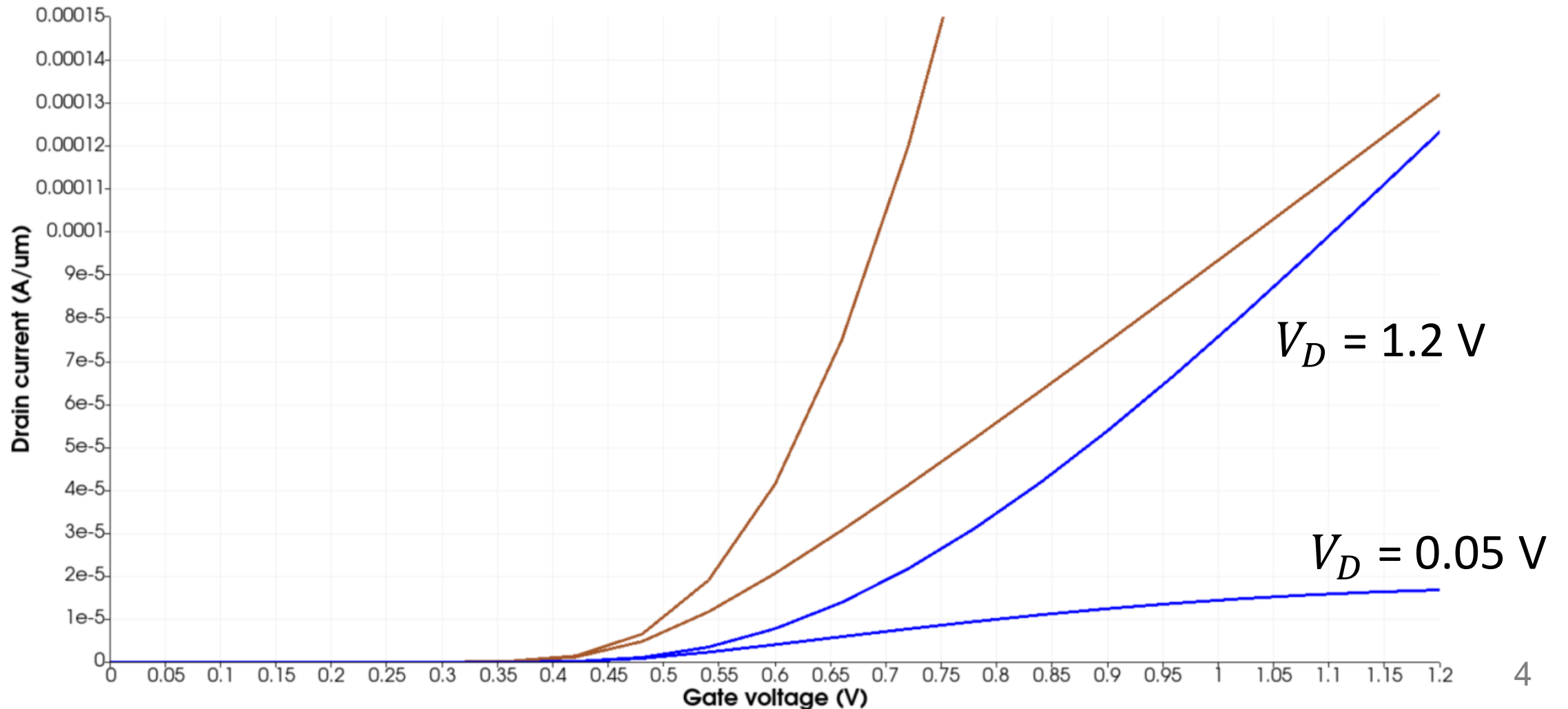
- Of course, we must include physical models.
  - Add the following lines.

```
property (thing="mosfet",model="mobility",mujtaba,canali)  
property (thing="mosfet",model="recombination",srh)
```

- Observe their effects.

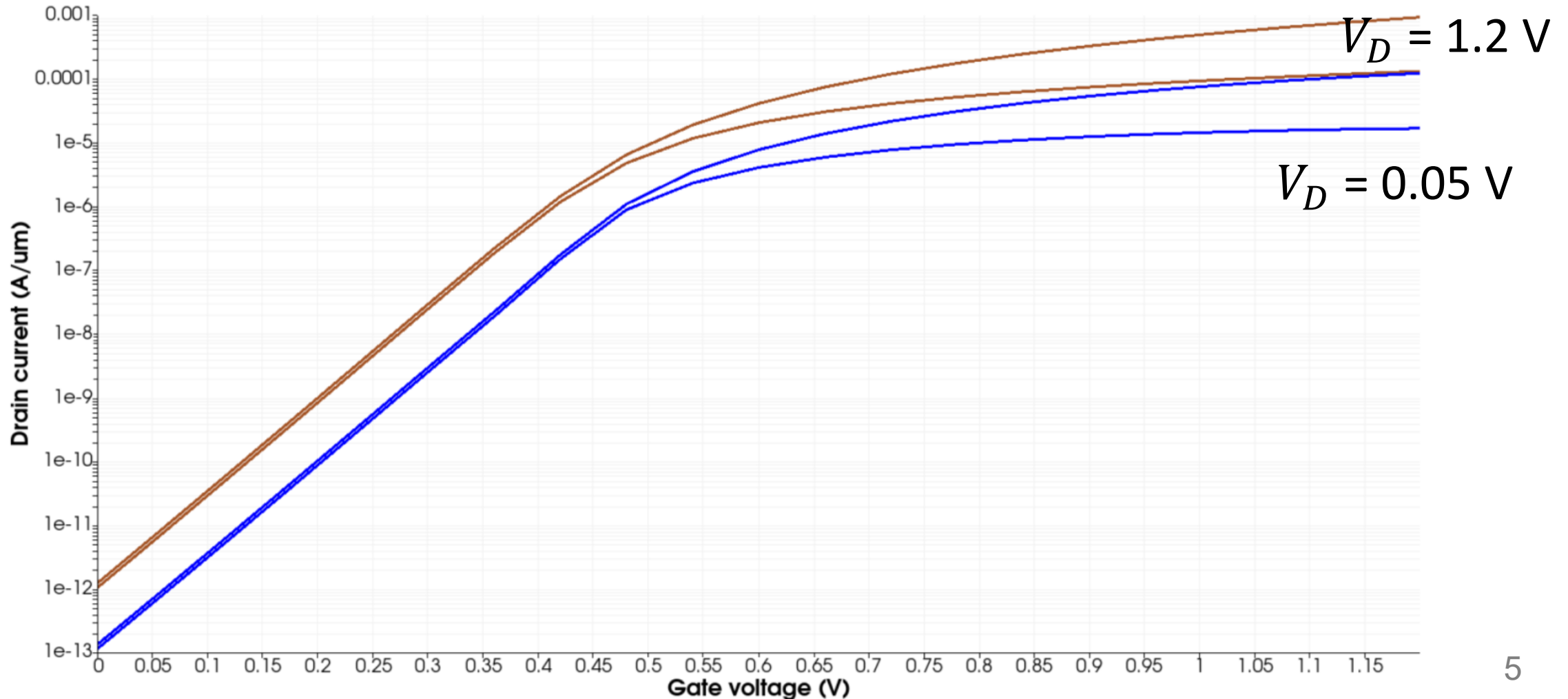
# Linear curve

- Significantly reduced current (Blue curves)



# Semi-logarithmic curve

- Significantly reduced current (Blue curves)



# Ramping the drain voltage up

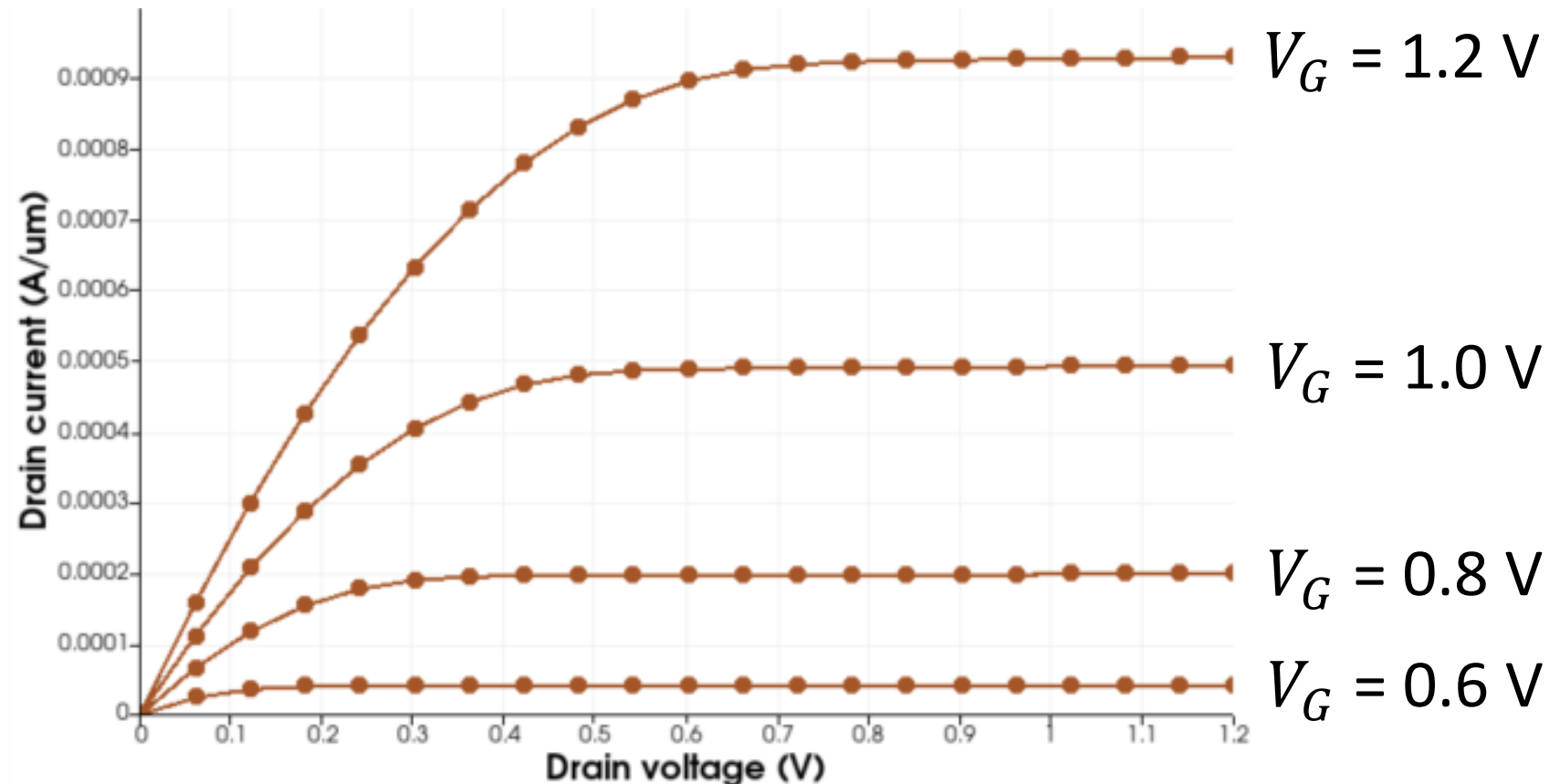
- We need several gate voltages.
  - Select a value and ramp up the gate voltage.
- Increase the drain voltage from 0 V to  $V_{DD}$ .

```
solve (law="dclaw", initialstep=0.05, maxstep=0.05, minstep=0.01, dozero,  
      plot, plotprefix="long_dc", cgns, book="output_iv") {  
  goal (thing="vd", quantity="voltage", value=1.2)  
}
```

- Repeat it with other  $V_G$  values.

# Without physical models

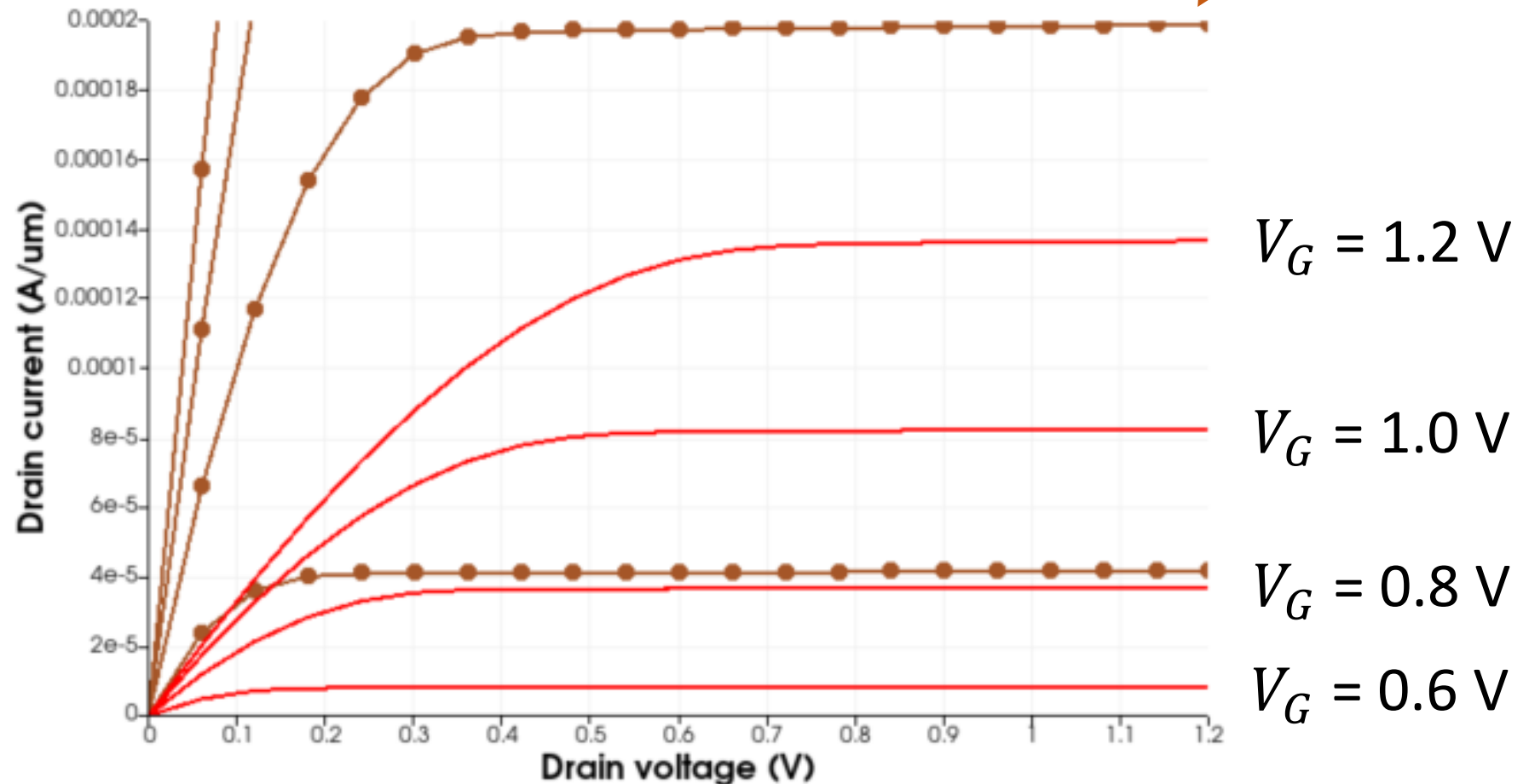
- Results WITHOUT any physical model from  $V_G = 0.6$  V to 1.2 V (0.2 V step)



# Inversion mobility model

- Results WITH inversion mobility model
  - Significantly reduced current (Brown versus red)

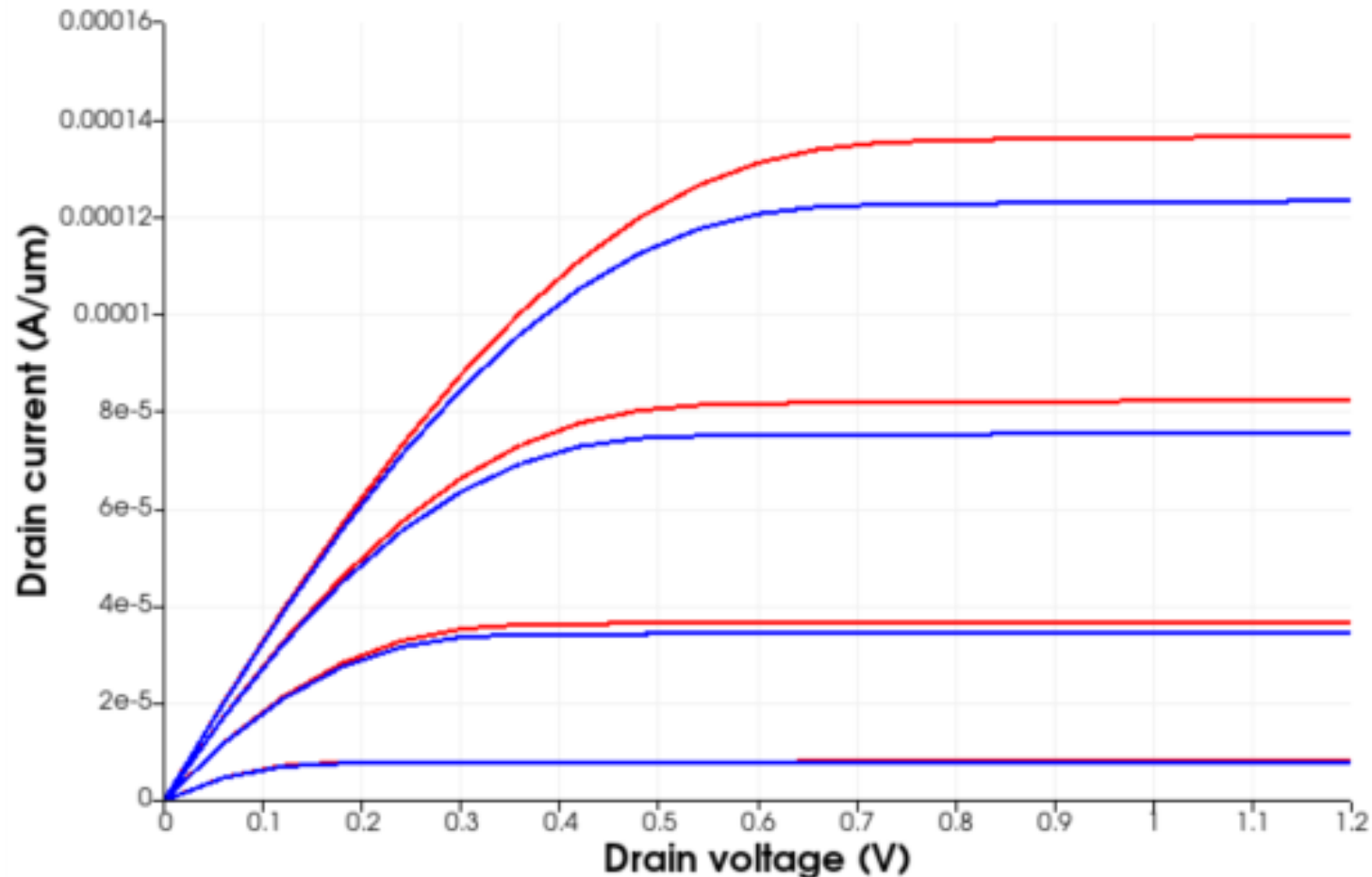
WITHOUT  
any model  
 $V_G = 0.8 \text{ V}$





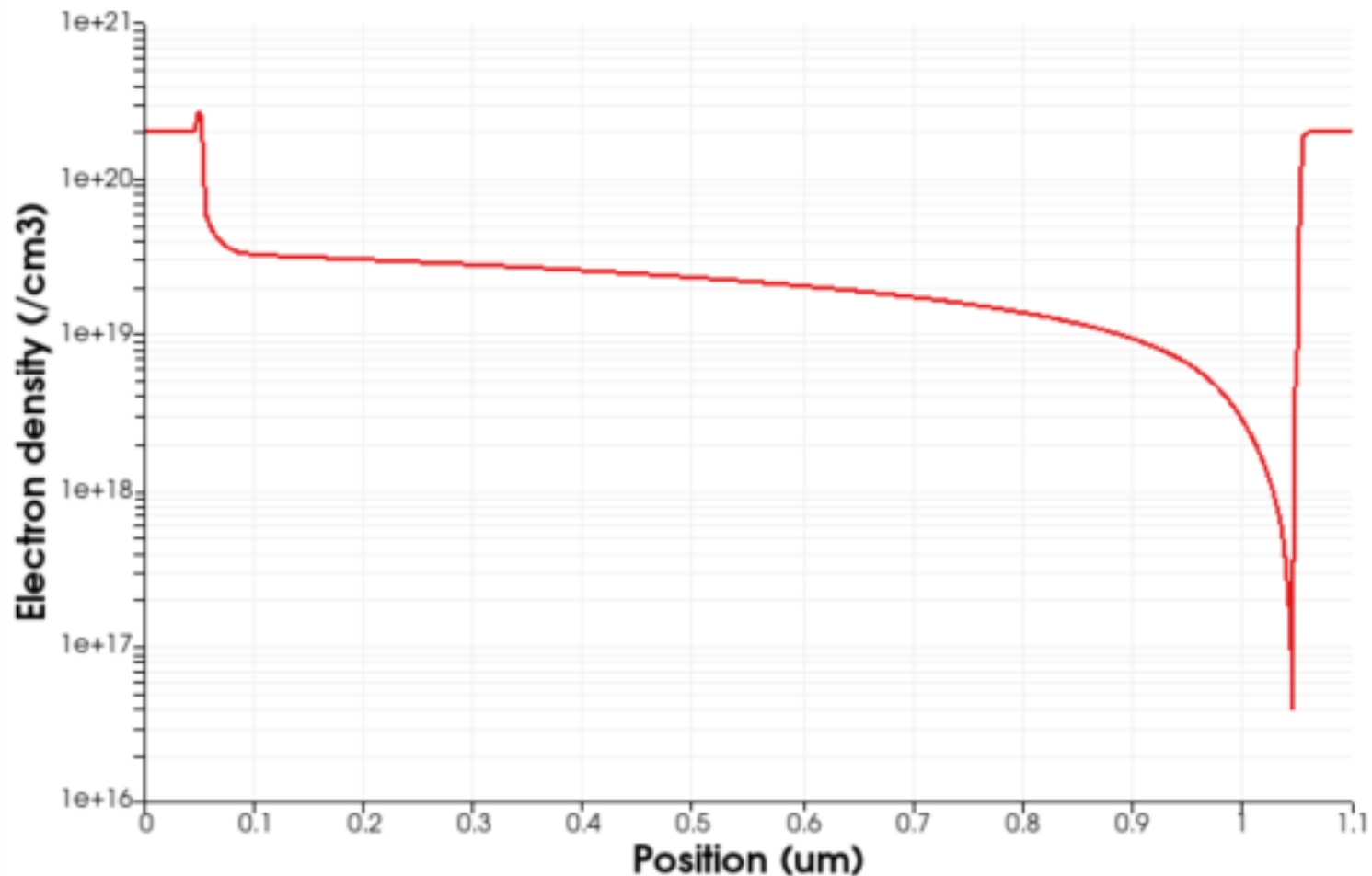
# Velocity saturation

- Results WITH inversion mobility model + velocity saturation



# Electron density

- Interface carrier density at  $V_G = V_D = V_{DD}$

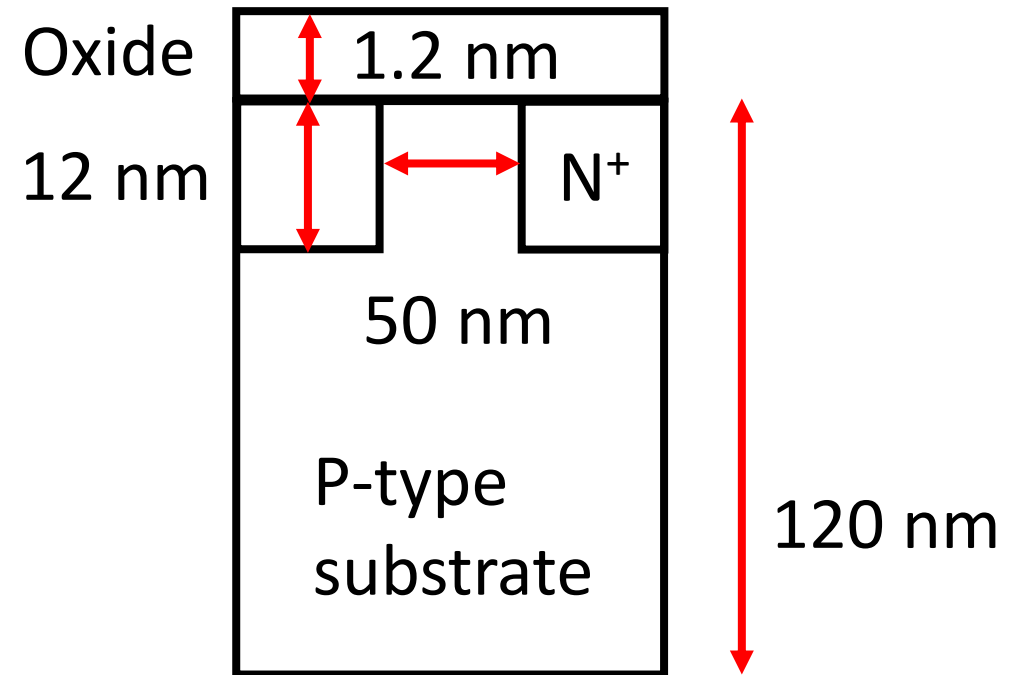


# Homework#18

- Due: 08:00 on Nov. 19
- Submit a report through the GIST LMS system.
  - From the input IV characteristics of our long-channel MOSFET, estimate the DIBL. (Of course, you must consider physical models.)

# Simulation of a short-channel MOSFET

- Effective oxide thickness of 1.2 nm
  - Gate workfunction of 4.3 eV
  - Substrate doping of  $1.5 \times 10^{18} \text{ cm}^{-3}$
  - $V_{DD}$  of 1.2 V
- Channel length of 50 nm
  - 1 nm spacing



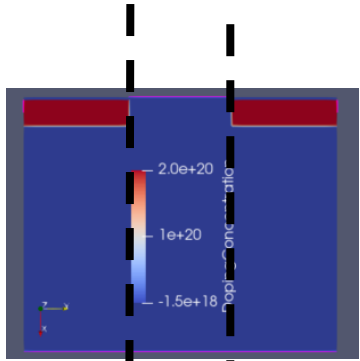
# Mapmaker

- Input file
  - $x$ : Depth
  - $y$ : Channel
  - $z$ : Width

```
thing (type="mapmaker",name="structure") {  
  mapmaker (type="3d",cgns="long.cgns") {  
    cuboid (x0=-1.2nm,y0=-550nm,x1=120nm,y1=550nm,z0=0.0,z1=1.0um,nx=102,ny=221,nz=2)  
    region (name="semiconductor",material="silicon",ix0=1,ix1=101,iy0=0,iy1=220,iz0=0,iz1=1)  
    region (name="insulator",material="oxide",ix0=0,ix1=1,iy0=0,iy1=220,iz0=0,iz1=1)  
    doping (region="semiconductor",ix0=1,ix1=101,iy0=0,iy1=220,iz0=0,iz1=1,density=-1.5e18/cm3)  
    doping (region="semiconductor",ix0=1,ix1=11,iy0=0,iy1=10,iz0=0,iz1=1,density=2e20/cm3)  
    doping (region="semiconductor",ix0=1,ix1=11,iy0=210,iy1=220,iz0=0,iz1=1,density=2e20/cm3)  
    contact (name="source",ix0=1,ix1=6,iy0=0,iy1=0,iz0=0,iz1=1)  
    contact (name="gate",ix0=0,ix1=0,iy0=10,iy1=210,iz0=0,iz1=1)  
    contact (name="drain",ix0=1,ix1=6,iy0=220,iy1=220,iz0=0,iz1=1)  
    contact (name="body",ix0=101,ix1=101,iy0=0,iy1=220,iz0=0,iz1=1)  
  }  
}
```

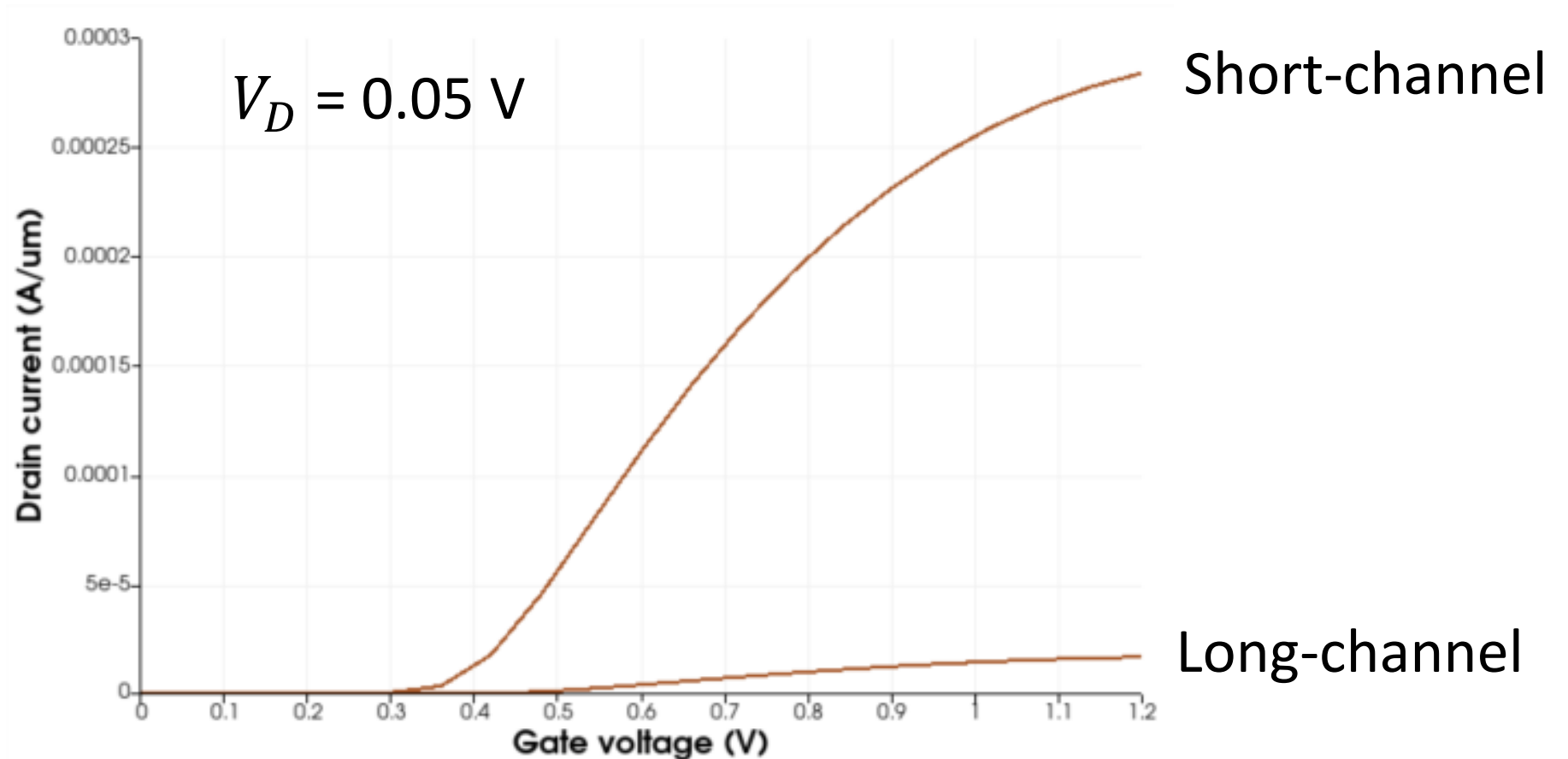
# Short and long structures

- Drawn in the same scale



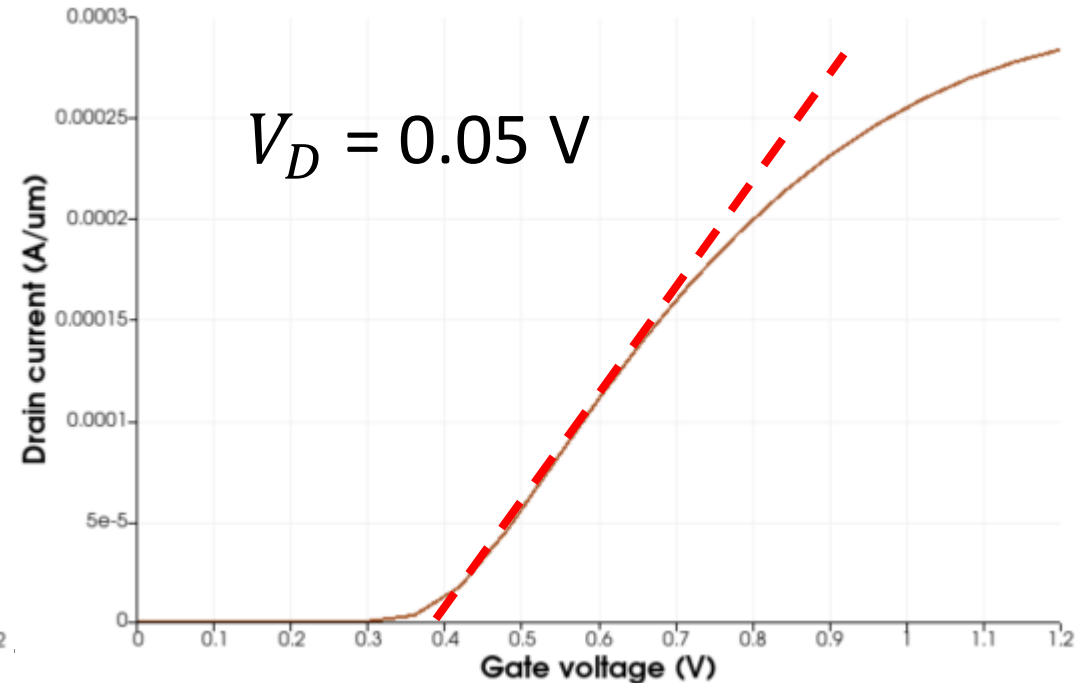
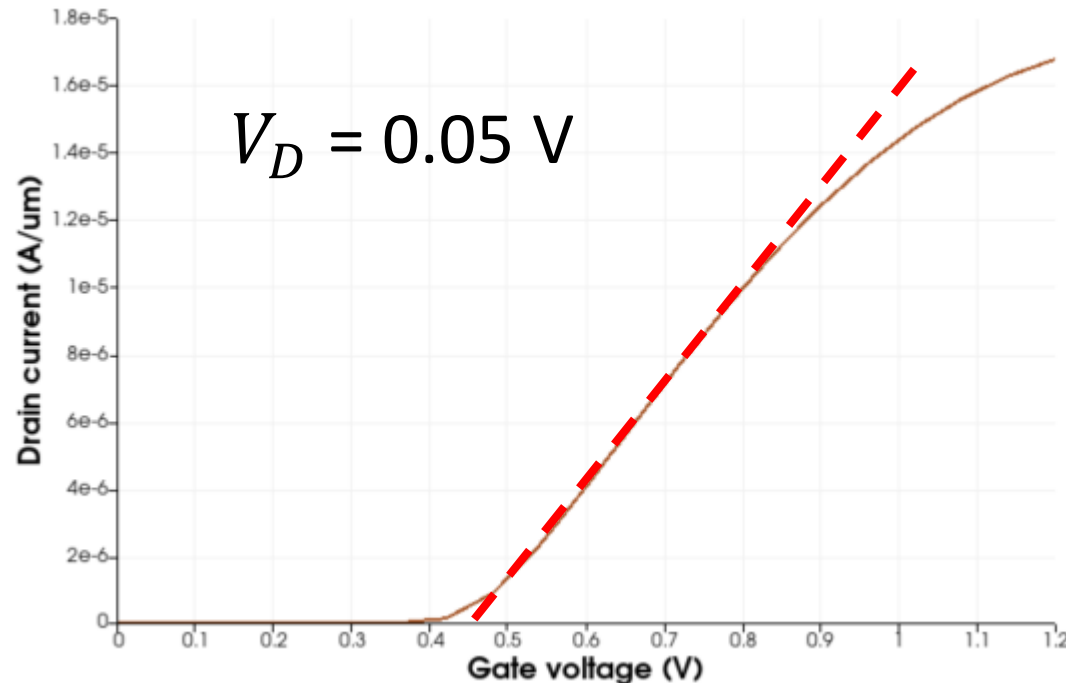
# Input characteristics

- Physical models included
  - Note that  $I_D \propto \frac{1}{L}$ .



# Reduction of $V_{TH}$ , even at a low $V_D$

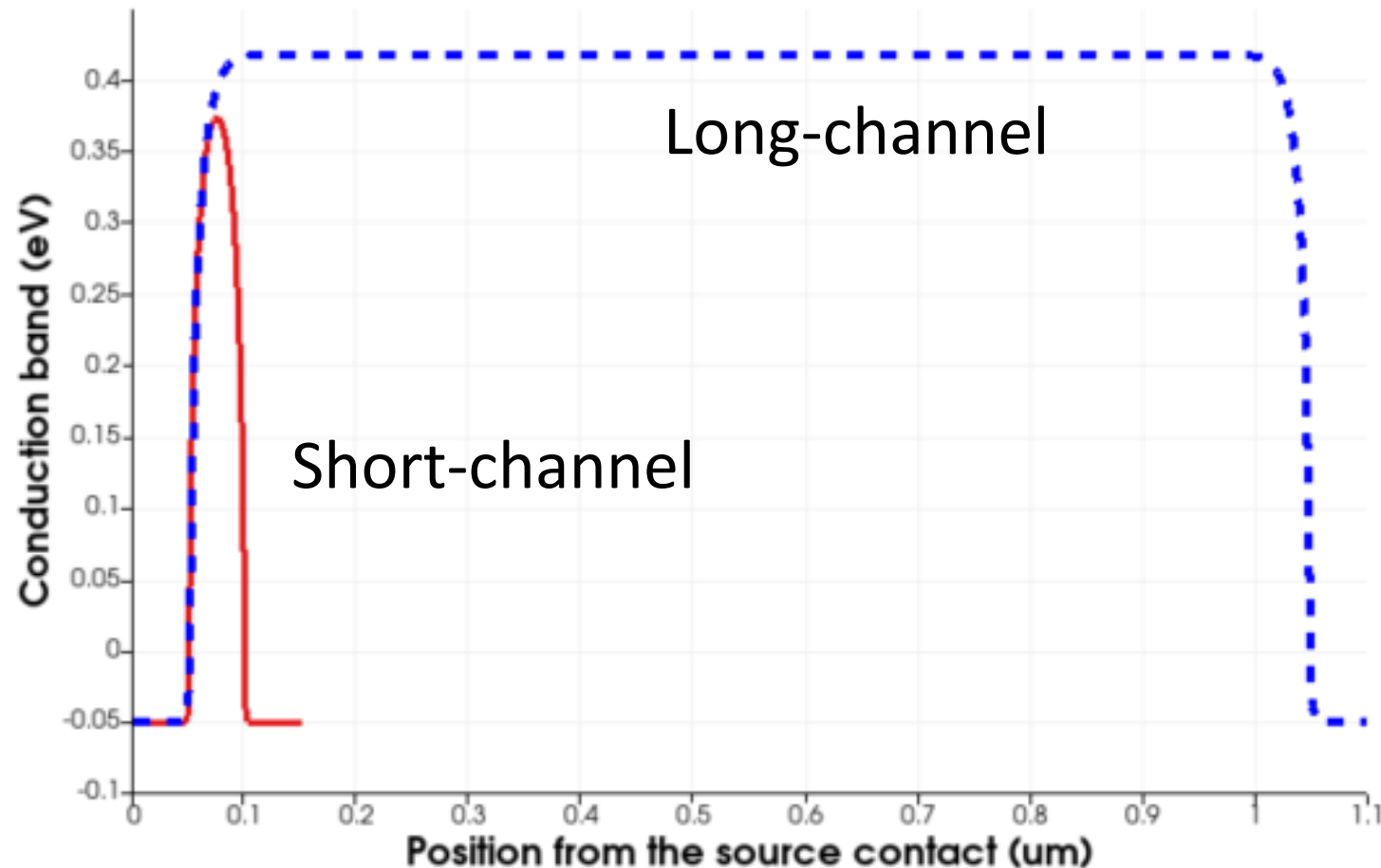
- For a short-channel device, the threshold voltage decreases.
  - $\sim 0.45$  V (Long-channel)
  - $\sim 0.4$  V (Short-channel)





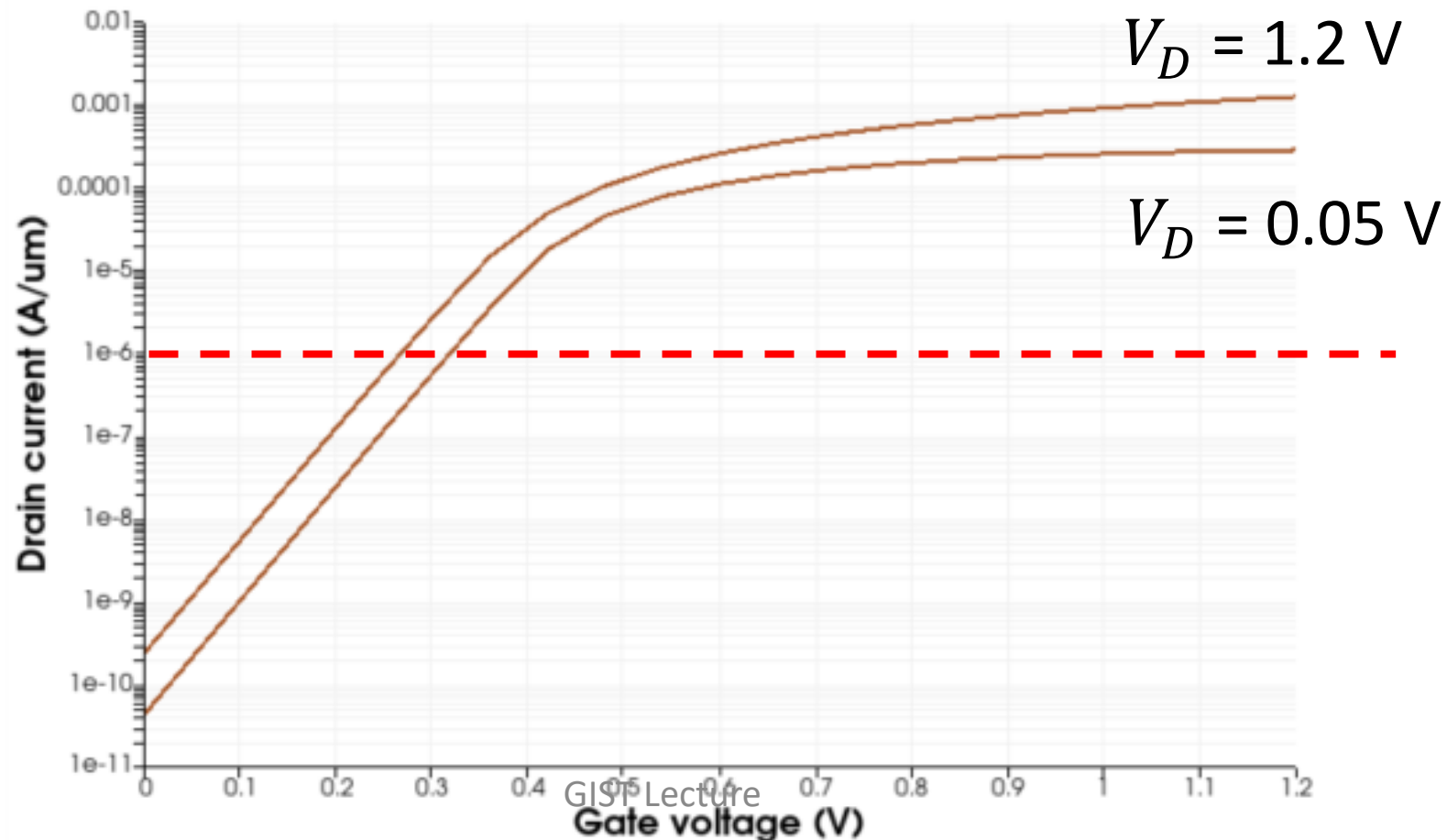
# Charge sharing

- Even at  $V_G = V_D = 0$  V, the conduction band profiles are different.



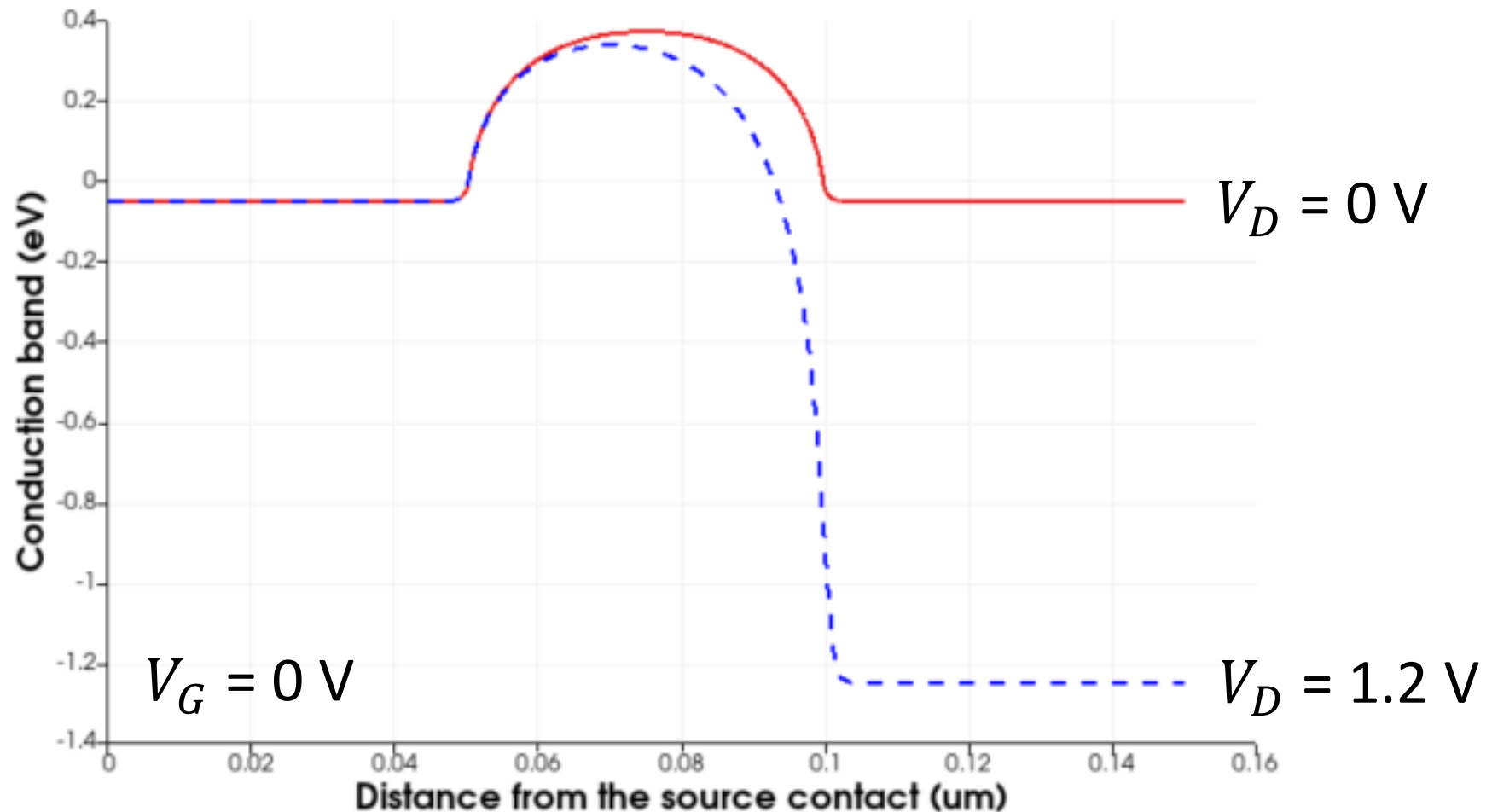
# DIBL

- Much worse than the long-channel device
  - 45 mV/V @  $I_D = 10^{-6}$  A/ $\mu\text{m}$



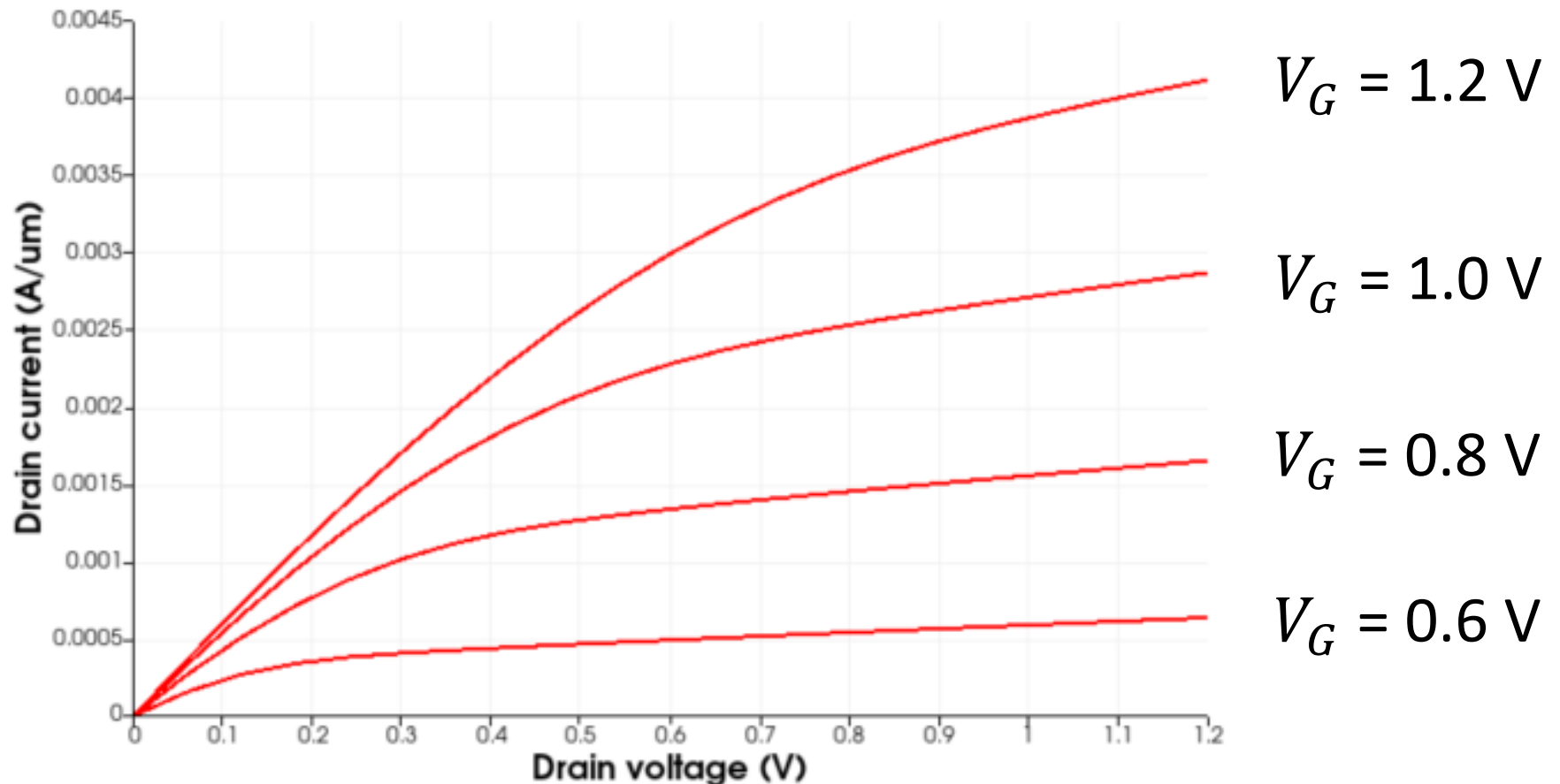
# Conduction band

- At a high  $V_D$ , the energy barrier is further reduced.



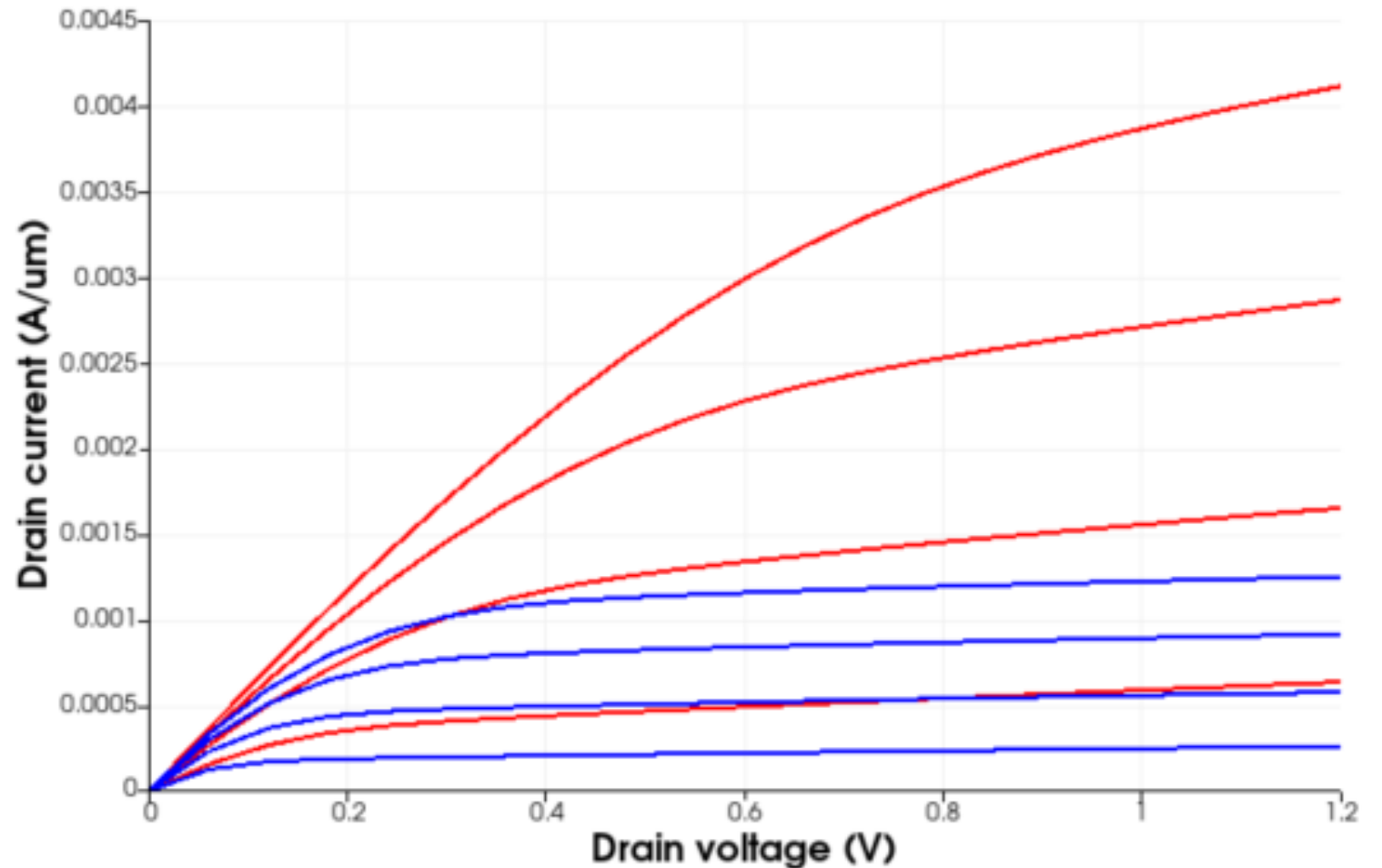
# Channel-length modulation

- Results WITH inversion mobility model (No velocity saturation)



# Velocity saturation

- Results WITH inversion mobility model + velocity saturation
  - Huge impact
  - Earlier saturation



# Thank you!